## Application/Control No. Applicant(s)/Patent Under Reexamination 10/698,394 SHIMIZU, TESSEI Notice of References Cited Examiner Art Unit Page 1 of 1 Thu Nguyen 3661 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,714,857 B2 03-2004 Α Kapolka et al. 701/123 US-6,636,790 B1 10-2003 В Lightner et al. 701/33 С US-D US-Ε US-F US-G US-Н US-US-1 US-J Κ US-US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 2002-197155 07-2002 Ν Japan Riu et al G06F 17/60 0 JP 2002-089349 03-2002 Satoshi et al Japan F02D 45/00 Р Q R s T **NON-PATENT DOCUMENTS**

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